TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ( $\pi$ -MOSIV)

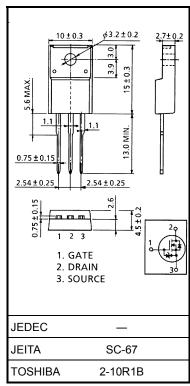
# 2SK4114

#### Switching Regulator Applications

- Low drain-source ON resistance: RDS (ON) = 2.2  $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 3.5 \text{ S} (typ.)$
- Low leakage current:  $IDSS = 100 \ \mu A (VDS = 720 V)$
- Enhancement model:  $V_{th}$  = 4.0~5.0 V ( $V_{DS}$  = 10 V,  $I_D$  = 1 mA)

# Absolute Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit	
Drain-source voltage		V <sub>DSS</sub>	900	V	
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		V <sub>DGR</sub>	900	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
Drain current	DC (Note 1)	۱ <sub>D</sub>	5	A	
	Pulse (t = 1 ms) (Note 1)	I <sub>DP</sub>	15		
Drain power dissipation (Tc = 25°C)		PD	45	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	595	mJ	
Avalanche current		I <sub>AR</sub>	5	А	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	4.5	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight: 1.9 g (typ.)

## **Thermal Characteristics**

Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	2.78	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C during use of the device.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 43.6 mH, I<sub>AR</sub> = 5.0 A, R<sub>G</sub> = 25  $\Omega$ 

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



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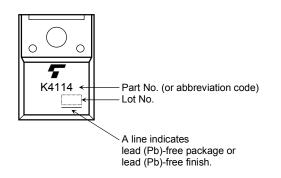
# **Electrical Characteristics (Ta = 25°C)**

Char	acteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 30 \text{ V},  V_{DS} = 0 \text{ V}$		—	±10	μA
Gate-source brea	akdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cutoff curre	ent	I <sub>DSS</sub>	$V_{DS} = 720 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		_	100	μA
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900	—		V
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	4.0	_	5.0	V
Drain-source ON	resistance	R <sub>DS (ON)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$		2.2	2.5	Ω
Forward transfer	admittance	Y <sub>fs</sub>	$V_{DS} = 20 V, I_D = 3 A$	1.5	3.5	_	S
Input capacitance		C <sub>iss</sub>			1150	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 25 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		20	_	
Output capacitance		C <sub>oss</sub>			110		
Switching time	Rise time	tr	$V_{GS}$ $0 V$ $I_D = 3 A V_{OUT}$ $V_{GS}$ $0 V$ $F_L = 66.7 \Omega$ $V_{DD} \simeq 200 V$	_	100		ns
	Turn-on time	t <sub>on</sub>			140	_	
	Fall time	t <sub>f</sub>			40		
	Turn-off time	t <sub>off</sub>	Duty $\leq$ 1%, t <sub>w</sub> = 10 $\mu$ s	_	130	_	
Total gate charge		Qg			25		
Gate-source charge		Qgs	$V_{DD}\simeq 400~V,~V_{GS}=10~V,~I_{D}=5~A$	_	11	—	nC
Gate-drain charge		Q <sub>gd</sub>	1	_	14	_	

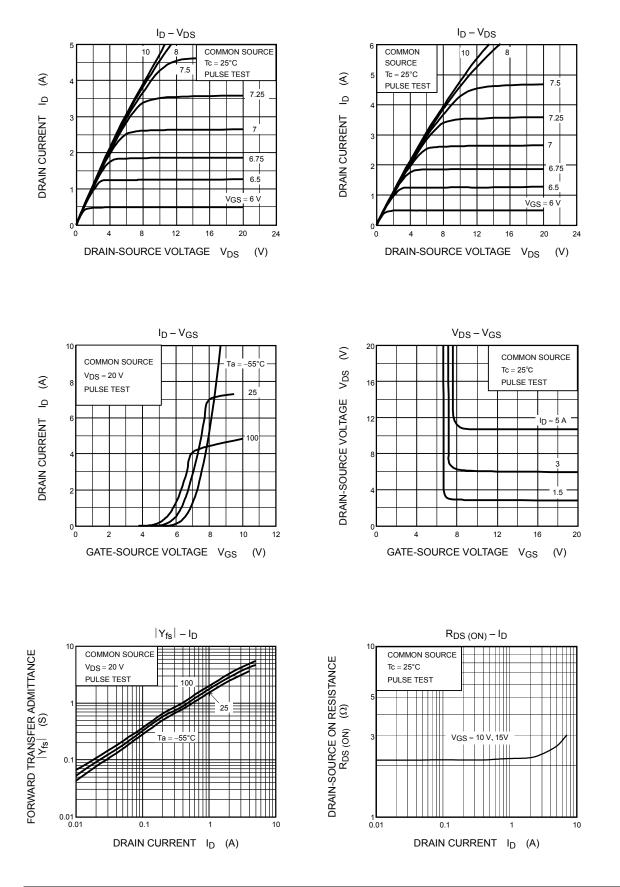
# Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	—	_	_	5	A
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	—	_	_	15	А
Forward voltage (diode)	V <sub>DSF</sub>	$I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	$I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V},$	_	900	_	ns
Reverse recovery charge	Q <sub>rr</sub>	dI <sub>DR</sub> /dt = 100 A/μs	_	5.4	_	μC

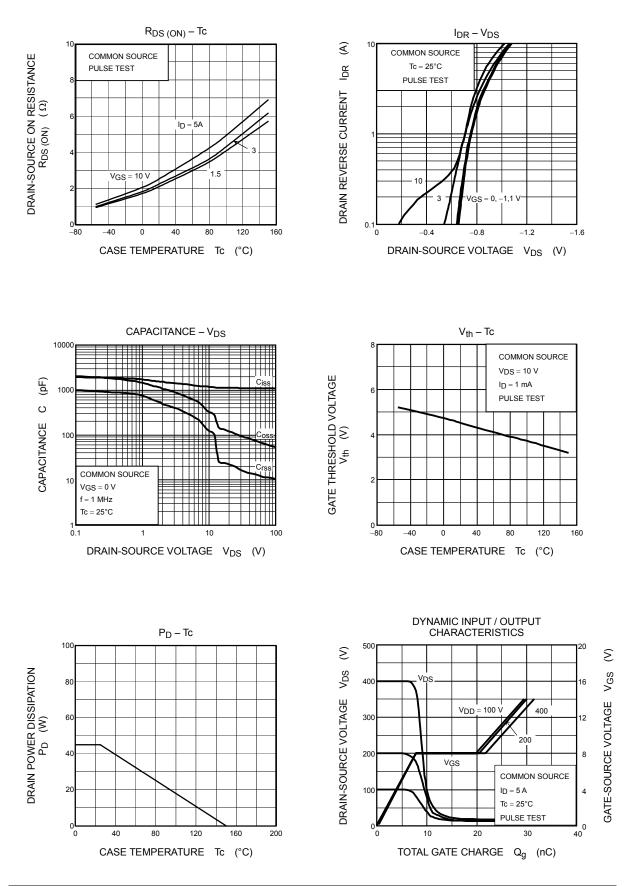
# Marking

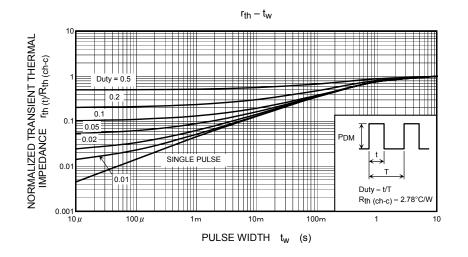


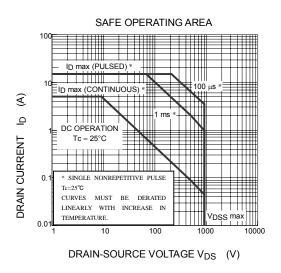
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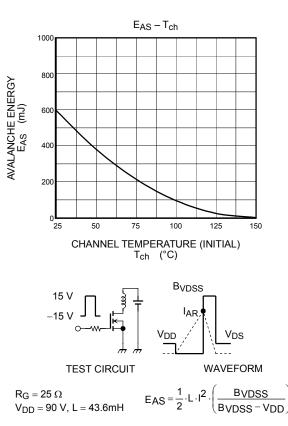


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